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Magnetism in nanometer-thick magnetite

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The oldest known magnetic material, magnetite, is of current interest for use in spintronics as a thin film. An open question is how thin can magnetite films be and still retain the robust ferrimagnetism required for many applications. We have grown 1-nm-thick magnetite crystals and characterized them *in situ* by electron and photoelectron microscopies including selected-area x-ray circular dichroism. Well-defined magnetic patterns are observed in individual nanocrystals up to at least 520 K, establishing the retention of ferrimagnetism in magnetite two unit cells thick.

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The trend in both magnetic data storage and spintronics is to reduce the thickness and/or lateral size of the device materials to the nanoscale. Size reduction in magnetic storage has the obvious advantage of increasing the bit density. Advantages also exist for spintronic applications. For example, the magnetic layers of spin filters can be switched with smaller magnetic fields as the layers become thinner. However, size reduction can also change a material's magnetic behavior. For example, as a ferromagnet is decreased in size, at some point thermal excitations can overcome the magnetic anisotropy energy, leading to superparamagnetism. Then the material is only useful below a "blocking" temperature, where the magnetization is stable over some relevant time scale. Several approaches are used to delay the onset of superparamagnetism, including using high magnetic anisotropy materials¹ or by exchange bias.² Understanding how to stabilize magnetic order in low-dimensional structures is an important concern.

Iron-containing oxides are a class of magnetic materials that provide good chemical stability in oxidizing atmospheres and have extremely high Curie temperatures. Strong magnetism in the iron oxide magnetite has been known since the ancient Greeks.³ The material, historically referred to as lodestone, is currently a promising candidate for spintronic applications.⁴ Bulk magnetite (Fe₃O₄) is a ferrimagnet with a 850 K Curie temperature⁵ and becomes multiferroic at low temperatures,^{6,7} allowing electrical control of magnetic domains. The prediction of half-metal character,⁸ which implies that the conduction electrons are 100% spin-polarized, led to its use as a spin injector.⁹

Oxides like magnetite have much more complicated structures and larger unit cells than metal ferromagnets, giving the possibility of tuning their properties to a larger extent, especially given the often observed strong coupling to strain effects. ^{10,11} Magnetite ultrathin nanostructures have been grown on a variety of substrates, including oxides, ^{12–18} semiconductors, ^{18–22} and metals. ^{23–28} Here we examine the presence of stable ferrimagnetic domains in ultrathin magnetite, a subject with conflicting reports in the literature. While some reports state than magnetite films close to 3 nm thick

present a well defined magnetic structure, ^{20,22,23,29,30} others indicate that clear signs of superparamagnetic behavior are observed at the same thickness. ^{12,31–34} We grow 1-nm-thick, micron-wide, magnetite crystals on ruthenium²⁵ using reactive molecular beam epitaxy (i.e., depositing iron in a background of oxygen) while monitoring the growth in real time by low-energy electron microscopy (LEEM²⁷). We show by imaging their individual magnetization patterns and their x-ray magnetic circular dichroism (XMCD) spectra that they are ferrimagnetic. The observation of magnetism near the limit of unit-cell thickness shows that, under appropriate conditions, there is still room to decrease the thickness of magnetite nanostructures without introducing superparamagnetism.

The experiments were performed at the Nanospectroscopy beamline of the Elettra storage ring.³⁵ The beamline facilities include an Elmitec III low-energy electron microscope with an hemispherical energy analyzer. The microscope has the option of selecting either an electron beam or an x-ray beam to probe the specimen surface. The electron beam allows for regular LEEM use, including fast real-space imaging of the surface during growth of the oxide films and selected-area diffraction measurements. In photoemission microscopy mode (PEEM), the instrument is able to record selected-area x-ray absorption spectra using the secondary electrons emitted subsequent to the x-ray absorption process, or spatially resolved photoemission images. The capability of selecting the polarization of the x-ray beam (plus or minus circular polarization) allows XMCD measurements. The x-ray beam is fixed relative to the sample at an angle of 16° with the film plane, so the XMCD measurements are mostly sensitive to the in-plane magnetization.

The Ru single-crystal substrate with (0001) orientation was cleaned by exposure to 5×10^{-8} mbar of molecular oxygen at 1000 K, followed by flashing to 1500 K in vacuum. The sample was oriented so that the incoming x-ray beam was aligned along a mirror plane of the Ru surface (i.e., along a [11 $\bar{2}$ 0] direction in real space). The iron oxide films were grown by reactive molecular beam epitaxy (MBE) in 5×10^{-7} mbar of molecular oxygen with the substrate at

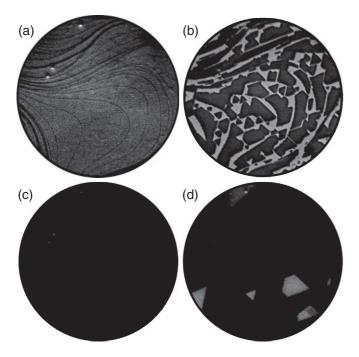


FIG. 1. (a)–(d) Selected LEEM images from a sequence acquired during the growth of the magnetite crystals. Panels (a)–(c) show the completion of the FeO layer, while the last frame shows the final film with magnetite crystals with well-defined edges. The field of view is $10~\mu m$ and the electron beam energy is 19~eV.

900 K. Iron was evaporated from a 2-mm-diameter iron rod heated by electron bombardment inside a water-cooling jacket. Oxygen was introduced into the experimental chamber by means of a capillary that increased the gas flux at the sample position by about a factor of 2.

Iron oxide growth on metal substrates using molecular oxygen as the oxidizing agent is expected to occur in two stages:²⁴ Initially, an FeO wetting layer covers the substrate, with a thickness that depends on the particular substrate. Then magnetite nucleates and grows as three-dimensional islands on the FeO film. This growth mode makes it difficult to obtain ultrathin magnetite crystals without actually imaging the film growth, as we do here. In Fig. 1 several frames are presented from a sequence of LEEM images acquired during iron oxide growth. In the experiment shown, the FeO initially grows as islands comprised of two Fe-O layers. (Along its [111] direction, FeO is composed of alternating planes of iron and oxygen.) When the FeO film is close to completely covering the substrate, some regions have a single FeO layer.

When further iron is deposited on a complete FeO film, large (up to several micrometers) triangular islands nucleate on top of the film [Figs. 1(d) and 2(a)].²⁷ These crystals and the FeO wetting layer are found to exhibit different low-energy electron diffraction (LEED) patterns [Fig. 2(a)], x-ray photoelectron spectroscopy (XPS) spectra [Fig. 2(b)], and x-ray absorption spectra (not shown).

The LEED patterns of the different oxide phases are known to differ. ²⁴ The diffracted beams that arise from the periodicity of the hexagonal oxygen layers appear at very similar positions in iron oxides due to their similar oxygen-oxygen distances, 0.297–0.320 nm. However, the different arrangement of the

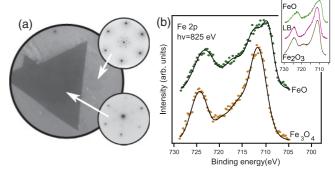


FIG. 2. (Color online) (a) LEEM image of a magnetite crystal (the field of view is 4 μ m and the electron energy is 8 eV), with insets showing the low-energy electron diffraction patterns (acquired using an electron beam of 28 eV) of the crystal and its surrounding wetting layer. (b) Fe 2p core-level x-ray photoelectron spectra acquired from the crystal (orange, lower curve) and the wetting layer (green, upper curve). The solid lines are the sum of the different individual contributions (not shown) that are expected to be present in the XPS spectra of FeO and magnetite. The inset shows reference spectra for FeO (top, green), a Langmuir-Blodgett film containing Fe²⁺ and Fe³⁺ (middle, purple), and hematite (bottom, gray). A nonlinear background has been substracted from the spectra.

iron atoms within the layers of each phase gives rise to 1×1 , 2×2 , and $\sqrt{3} \times \sqrt{3}R30^{\circ}$ LEED patterns for bulk-terminated FeO(111), magnetite(111), and hematite(0001), respectively. As seen in Fig. 2(a), the wetting layer has a 1×1 LEED pattern (with additional spots due to a coincidence pattern with the underlying Ru substrate), suggesting a FeO(111) surface. In contrast, the large triangular crystal has a 2×2 LEED pattern, which is indicative of magnetite. The island's oxygen lattice spacing obtained from LEED is the same as the wetting layer, 0.32 ± 0.04 nm; that is, the magnetite crystals are strained by 6%. We note this oxygen in-plane distance is different from the magnetite spacing reported in Ref. 25 which was grown by deposition of Fe and postoxidation in oxygen. The easiest explanation is that our magnetite crystals are grown epitaxially on the underlying FeO wetting layer. We note, nevertheless, that anomalous in-plane expansions have been reported for ultrathin (111) magnetite films grown on Al₂O₃ (Ref. 36). Further work will be needed to understand the detailed strain evolution in ultrathin magnetite crystals.

Aimed at identifying more precisely the chemical nature of the triangular crystals, the Fe 2p core level XPS spectra were recorded from a crystal and from its surrounding iron oxide layer [Fig. 2(b)]. For comparison, the inset shows the same Fe 2p core level peaks recorded from several iron compounds obtained using a conventional laboratory XPS spectrometer. [The upper spectrum corresponds to an FeO film produced by vacuum evaporation of Fe metal on a Ru substrate and subsequent oxidation; the middle spectrum corresponds to a 3-nm-thick Fe-containing film produced by the Langmuir-Blodgett (LB) technique that contains both Fe²⁺ and Fe³⁺ (Ref. 37); the bottom spectrum was obtained from pure α -Fe₂O₃ powder.] The spectrum from the wetting layer [Fig. 2(b), top curve] presents the same features as the reference FeO film, confirming that the wetting layer is FeO. In contrast, the main photoemission peaks in the Fe 2p spectrum

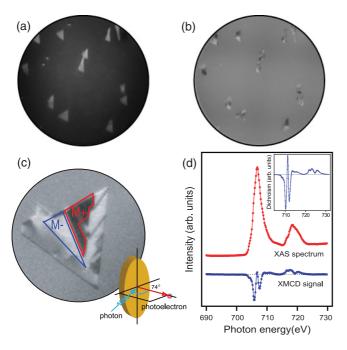


FIG. 3. (Color online) (a) XAS and (b) XMCD image at 705.8 eV. The field of view is 30 μ m. (c) XMCD image recorded in remanence showing the magnetization pattern of the same crystal presented in Fig. 2(a). The field of view is 4 μ m. The inset shows the experimental geometry. (d) (Top) XAS spectrum from the magnetite crystal. (Bottom) XMCD difference spectrum. The inset shows a typical XMCD spectra from stoichiometric magnetite (reprinted with permission from Ref. 45).

from the triangular crystal [Fig. 2(b), bottom curve] appear at higher binding energies than those in the wetting-layer spectrum, indicating that the average Fe oxidation state in the crystal is higher than in the wetting layer. The characteristic shake-up satellite of exclusively Fe³⁺-containing phases (i.e., the peak at 718–719 eV) is not evident in the crystal's spectrum. The spectrum thus resembles that of the mixed Fe^{2+} - Fe^{3+} LB film shown in the middle of the inset of Fig. 2(b), indicating that the crystal is a mixed-valence Fe²⁺/Fe³⁺ oxide. Consistently the octahedral positions in magnetite's inverse spinel structure⁵ are populated with both Fe²⁺ and Fe³⁺ while the tetrahedral positions are occupied only by Fe³⁺. This result together with the LEED pattern [and the XMCD spectra of Fig. 3(d)] indicate that the ultrathin crystals are indeed magnetite. We cannot, however, evaluate their detailed stoichiometry. (Magnetite is often nonstoichiometric.)

We use XMCD in PEEM³⁸ to reveal *in situ* the magnetic order of the individual magnetite crystals. To measure the x-ray absorption (XAS) spectra for the magnetite crystals, an image of the secondary electron emission (which is proportional to the XAS) was collected while the photon energy was scanned over the Fe L_{3,2} XAS edges in two different scans using opposite x-ray helicities. Such a XAS image, acquired close to the Fe L₃ absorption edge, is shown in Fig. 3(a). The image intensity from the area corresponding to the magnetite crystal of Fig. 2(a) was integrated and averaged for the two x-rays helicities, giving the XAS spectrum shown in Fig. 3(d) (top curve). The spectrum provides further support that the crystal is magnetite,³⁹ which has a significant XMCD signal^{40–42} at

the shoulder before the maximum of the L₃ XAS spectra. Taking images at this photon energy (705.8 eV) with different helicities and subtracting them pixel by pixel gives the XMCD images of Fig. 3(b) (larger field of view of 30 μ m, showing the well-separated magnetite crystals, all of which present magnetic domains) and Fig. 3(c) [where the same island of Fig. 2(a) is shown]. The uniform gray intensity of the FeO wetting layer indicates that it has no magnetic circular dichroic contrast. We thus do not find any ferromagnetic order such as the one observed on FeO/Fe(110) (Ref. 43), in agreement with the antiferromagnetic order expected both in bulk FeO (which is antiferromagnetic with a Néel temperature below room temperature⁵) and in an ultrathin FeO film on Pt(111) (Ref. 44). In contrast, the magnetite crystals show a clear dichroic contrast, establishing that they have nonzero local magnetization. The magnetic domain patterns [Fig. 3(c)] are intricate, with long straight domain walls oriented along the {112} directions of the magnetite crystal. The two domains marked as M+ and M- in Fig. 3(c) have the similar magnitude of the magnetization component along the illumination direction of the x-ray beam. The magnetization pattern persists during annealing up to 520 K, where changes in the surface topography are already detected.

In order to calculate the dichroic XMCD spectra, only the area that corresponds to a given domain in a XAS image with a given helicity is selected: a different XAS spectra can be collected for each specific combination of domain type (M+, M-) and x-ray polarization (P+, P-). To avoid spurious signals, the I(+M, +P) and I(-M, +P)curves were subtracted together, as were the I(+M, -P) and the I(-M, -P) curves. Then each of the two difference spectra for +P and -P are subtracted from one another, after normalizing by the difference in XAS intensity in the wetting layer to account for illumination differences. The XMCD difference spectrum [Fig. 3(d), bottom curve] shows a well-defined peak structure at the L₃ and L₂ edges that is characteristic of magnetite⁴² (the inset shows the XMCD difference spectrum from stoichiometric magnetite). The two negative peaks at the L₃ edge originate mostly from the iron cations sitting at the octahedral sites, with nominal valences +2and +3. The positive peak in the middle corresponds mostly to the tetrahedral Fe³⁺ ions. The opposite sense of the XMCD peaks from the iron cations at octahedral and tetrahedral sites indicates their mutual antiferromagnetic coupling. Thus, the magnetite crystals are ferrimagnetic, like the bulk material. The tetrahedral peak is smaller and the octahedral Fe²⁺ peak is larger than for bulk magnetite.⁴² These differences are usually assigned to nonstoichiometric magnetite.⁴⁵ In our case, they are likely to arise from contributions from the underlying FeO wetting layer⁴⁶ or from an incomplete unit cell.²⁹

We next accurately measure the thickness of individual magnetite crystals. We use the 40-nm real-space resolution of PEEM to measure the attenuation of the photoelectrons emitted from the Ru 3d core level of the substrate when emerging through individual magnetite crystals (Fig. 4). This method requires an accurate value of the mean free path of electrons traveling through the magnetite crystal at a given kinetic energy. For 400-eV photons the electrons from the Ru $3d_{5/2}$ core level have a kinetic energy of 120 eV. The

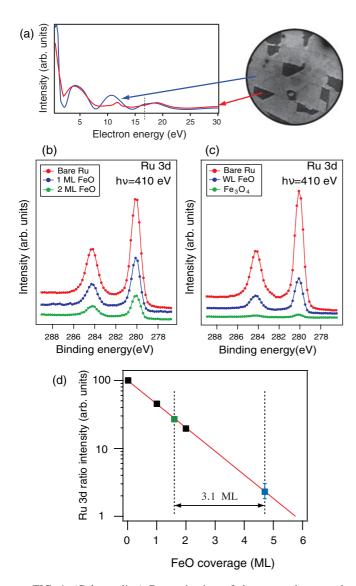


FIG. 4. (Color online) Determination of the magnetite crystal thickness. (a) (Left) Electron reflectivity curves recorded from two regions of a continuous FeO film, in blue for the majority area (which appears light gray in the LEEM image on the right side and corresponds to a FeO bilayer) and in red for the minority regions (which appear in dark gray in the LEEM image and correspond to a FeO single layer). (Right) LEEM image of a complete FeO layer before growth of the magnetite crystals. (The electron energy is 16.75 eV and the field of view is 4 μ m.) (b) Ru 3d XPS spectra recorded from clean Ru through a FeO monolayer and bilayer respectively. (c) Ru 3d XPS spectra recorded from clean Ru through the wetting layer around the magnetite crystals and through the magnetite crystals, respectively. (d) Semilogarithmic plot of the relative Ru XPS $3d_{5/2}$ peak area recorded from the different films versus coverage in FeO layers. The black squares correspond to the spectra in (b), which give a mean free path of 1.25 ± 0.03 ML_{FeO} (line in the semilogarithmic plot). The green and blue squares correspond to the wetting layer and the magnetite crystal, respectively, from (c) (error bars from the wetting layer are within the symbol size). The additional thickness of the magnetite crystal does not depend on the particular wetting layer thickness.

attenuation of a single FeO layer was measured by comparing the spectral area of the Ru $3d_{5/2}$ core level from bare Ru, measured through a FeO bilayer and through a single FeO layer (see Fig. 4). The bilayer and single layer areas of FeO are easily distinguished not only by the difference in the substrate core level attenuation but by their electron reflectivity [Fig. 4(a)]. The FeO bilayer presents an additional peak absent from the FeO monolayer. (Oscillations in electron reflectivity with energy arise from the interference between electrons reflected from the film/substrate and film/vacuum interfaces,⁴⁷ with each additional peak indicating one additional layer.) Using the experimentally determined mean free path for 120-eV electrons in FeO [1.25 \pm 0.02 FeO layers, Fig. 4(d)], the thickness of the magnetite crystal was estimated to be 3.1 ± 0.3 FeO layers. Given the relative density of the Fe-O layers in magnetite and in FeO (same oxygen density, 25% smaller iron density for magnetite), the thickness of the Fe-O layers in magnetite $[0.242 \pm 0.06 \text{ nm}^{24}]$ yields a thickness for the magnetite crystals of 1.0 ± 0.4 nm (the larger relative error for the thickness in nm is due to the conservative estimate of the influence of the relative density of magnetite Fe-O layers in magnetite and FeO). To put this number into context we note that the thinnest magnetite film grown on a metal substrate (with a similar FeO interface layer²⁴) reported to date with a well-defined bulklike local magnetic structure, determined by conversion electron Mössbauer spectroscopy, was around three times thicker than our islands.²³ In contrast, thinner films often show a marked superparamagnetic behavior such as for 1.8 nm magnetite on spinel films reported by Eerenstein et al.33 Antiphase boundaries (APB) are often blamed for the appearance of superparamagnetism. 34,48 Our crystals, arising from a single nuclei each, probably do not have APBs (in agreement with the size of the magnetic domains detected) nor many stacking boundaries (as deduced from previous dark field imaging; see Fig. 7 in Ref. 27). This low density of defects might account for the stable magnetization domains in our thin magnetite crystals. In contrast, complete magnetite films formed from coalescence from different nuclei often contain APBs⁴⁸ and twin boundaries.

In summary, we have grown 1-nm-thick crystals of iron oxide on a metal substrate. Electron diffraction, Fe core level photoelectron spectroscopy, and XAS spectroscopy establish that the crystals are magnetite. XMCD reveals that individual ultrathin crystals have ferrimagnetic order up to 520 K. With thickness of only two unit cells, the crystals may well be the thinnest lodestone ever and they establish that magnetite's robust magnetism is preserved at the nanometer limit.

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